

Notice of References Cited	Application/Control No. 10/509,598	Applicant(s)/Patent Under Reexamination BAKKERS, ERIK PETRUS ANTO	
	Examiner Matthew W. Such	Art Unit 2891	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,293,037	03-1994	Le Mehaute et al.	250/214.1
*	B	US-2001/0028055	10-2001	Fafard et al.	257/17
*	C	US-2002/0190249	12-2002	Williams et al.	257/14
*	D	US-6,978,070	12-2005	McCarthy et al.	385/123
*	E	US-5,679,961	10-1997	Higurashi et al.	257/14
*	F	US-6,121,157	09-2000	Nakajima, Anri	438/737
*	G	US-5,899,734	05-1999	Lee, Hong Hee	438/584
*	H	US-5,604,154	02-1997	Takahashi et al.	438/694
*	I	US-6,998,310	02-2006	Fraboulet et al.	438/268
*	J	US-5,670,790	09-1997	Katoh et al.	257/14
*	K	US-6,843,902	01-2005	Penner et al.	205/76
*	L	US-H0,001,570	08-1996	Lux et al.	257/25
*	M	US-5,567,954	10-1996	Dobson et al.	257/3

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Sze, S. M. "PHYSICS OF SEMICONDUCTOR DEVICES." 2 nd Ed. John Wiley & Sons: New York (1981): pp. 772-783.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/509,598	Applicant(s)/Patent Under Reexamination BAKKERS, ERIK PETRUS ANTO	
	Examiner Matthew W. Such	Art Unit 2891	Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,347,140	09-1994	Hirai et al.	257/17
*	B	US-5,917,194	06-1999	Dutta et al.	257/17
*	C	US-5,972,744	10-1999	Morimoto et al.	438/197
*	D	US-7,041,539	05-2006	Fraboulet et al.	438/158
*	E	US-6,570,224	05-2003	Ilyanok, Alexander Mikhailovich	257/350
*	F	US-6,191,432	02-2001	Sugiyama et al.	257/19
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.